**UPG15N65** 

**Preliminary** 

Insulated Gate Bipolar Transistor

# 650V, SMPS N-CHANNEL IGBT

#### DESCRIPTION

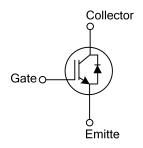
Ths UPG15N65 is a Insulated Gate Bipolar Transistor (IGBT) features a robust and cost effective Non-Punch Through (NPT) Trench construction, and provides superior performance in demanding switching applications.

Offering both low on state voltage and minimal switching loss, the IGBT is well suited for motor drive control and other hard switching applications.

#### **FEATURES**

- \*  $V_{CE(SAT)} \le 2.5V @ I_C=15A, V_{GE}=15V$
- \* 650V Switching SOA Capability
- \* Low Saturation Voltage Resulting in Low Conduction Loss
- \* Low Switching Loss in Higher Frequency Applications
- \* 5µs Short Circuit Capability
- \* Excellent Current

## **SYMBOL**



#### **ORDERING INFORMATION**

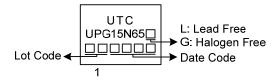
Ordering Number		Dookogo	Pin	Assignn	Dooking		
Lead Free	Halogen Free	Package	1	2	3	Packing	
UPG15N65L-TF3-T	UPG15N65G-TF3-T	TO-220F	G	С	E	Tube	

E: Emitter

C: Collector

Note: Pin Assignment: G: Gate UPG15N65G-TF3-T (1)Packing Type (1) T: Tube (2)Package Type (2) TF3: TO-220F (3)Green Package (3) G: Halogen Free and Lead Free, L: Lead Free

#### **MARKING**



TO-220F

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## ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Collector-Emitter Voltage		$V_{CES}$	650	V
Gate to Emitter Voltage Continuous		$V_{\sf GES}$	±20	V
Oti	T <sub>C</sub> =25°C	Ic	30	Α
Continuous Collector Current	T <sub>C</sub> =100°C		15	Α
Collector Current Pulsed (Note 2)		$I_{CM}$	60	Α
Peak Diode Recovery dv/dt (Note 3)		dv/dt	6.4	V/ns
Power Dissipation		$P_D$	30	W
Junction Temperature		$T_J$	-55 ~ <b>+</b> 150	°C
Storage Temperature Range		T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3.  $I_F \le 8.0 A$ , di/dt  $\le 200 A/\mu s$ ,  $V_{CC} \le BV_{CES}$ , Starting  $T_J = 25 ^{\circ}C$

#### **■ THERMAL DATA**

PARAMETER	SYMBOL	RATING	UNIT
Junction to Case	$\theta_{\text{JC}}$	4.17	°C/W

## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub>=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
Collector-Emitter Breakdown Voltage	$BV_CES$	I <sub>C</sub> =250μA, V <sub>GE</sub> =0V		650			V	
Collector-Emitter Leakage Current	I <sub>CES</sub>	V <sub>CE</sub> =650V, V <sub>GE</sub> =0V				200	μΑ	
Gate to Emitter Leakage Current	$I_{GES}$	V <sub>GE</sub> =20V, V <sub>GE</sub> =0V				±400	nA	
Collector-Emitter Saturation Voltage	V <sub>CE(SAT)</sub>	I <sub>C</sub> =15A, V <sub>GE</sub> =15V	TJ=25°C		2.0	2.5	V	
			T <sub>J</sub> =125°C		2.4		V	
Gate to Emitter Threshold Voltage	$V_{GE(TH)}$	$I_C$ =250 $\mu$ A, $V_{CE}$ = $V_{GE}$		4.0		7.0	V	
Input Capacitance	C <sub>IES</sub>	V <sub>CE</sub> =30V, V <sub>GE</sub> =0V, f=1MHz			800		pF	
Output Capacitance	$C_OES$				88		pF	
Reverse Transfer Capacitance	$C_RES$				15		pF	
Total Gate Charge	$Q_{G}$	V <sub>CE</sub> =100V, V <sub>GE</sub> =10V, I <sub>C</sub> =15A			30		nC	
Gate-Emitter Charge	$Q_GE$				10		nC	
Gate-Collector Charge	$Q_GC$				14		nC	
Current Turn-On Delay Time	t <sub>D(ON)</sub>	$V_{CE}$ =100V, $V_{GE}$ =15V, $I_{C}$ =15A, $R_{G}$ =24 $\Omega$			10		ns	
Current Rise Time	$t_R$				24		ns	
Current Turn-Off Delay Time	t <sub>D(OFF)</sub>				90		ns	
Current Fall Time	t <sub>F</sub>				75		ns	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Forward Voltage Drop	$V_{FM}$	I <sub>F</sub> =15A				2.6	V	
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =15A, dI/dt=100A/μS			100		ns	
Reverse Recovery Charge	Q <sub>rr</sub>				230		nC	

Note: Pulse Test: Pulse width ≤ 50 µs.

### **■ TEST CIRCUIT AND WAVEFORMS**

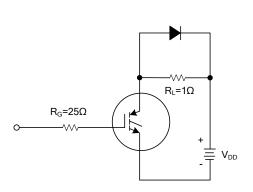


Fig 1. INDUCTIVE SWITCHING TEST CIRCUIT

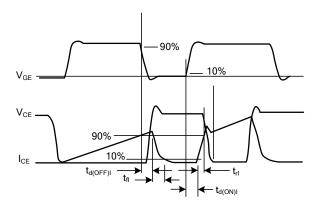


Fig 2. SWITCHING TEST WAVEFORMS

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